



GM72V661641DI/DLI

1,048,576 WORD x 16 BIT x 4 BANK
SYNCHRONOUS DYNAMIC RAM

Description

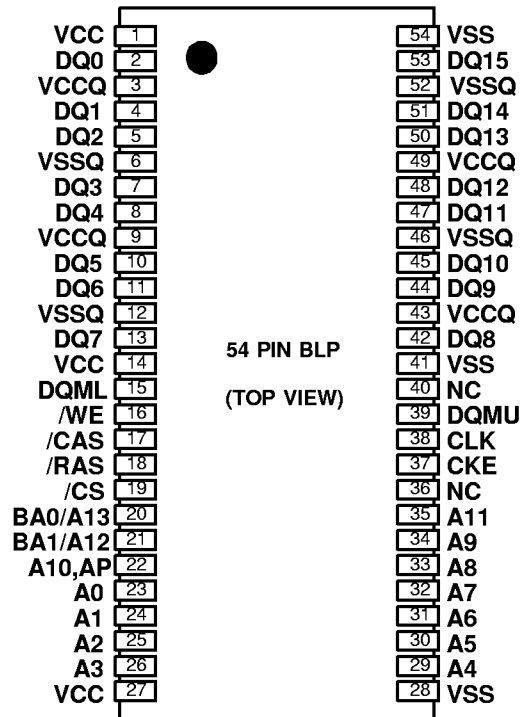
The GM72V661641DI/DLI is a synchronous dynamic random access memory comprised of 67,108,864 memory cells and logic including input and output circuits operating synchronously by referring to the positive edge of the externally provided clock.

The GM72V661641DI/DLI provides four banks of 1,048,576 word by 16 bit to realize high bandwidth with the clock frequency up to 125 Mhz.

Features

- * PC100, PC66 Compatible
7K(2-2-2), 7J(3-2-2), 10K(PC66)
- * 3.3V single power supply
- * LVTTTL interface
- * Max clock frequency
100/125 MHz
- * 4,096 refresh cycle per 64 ms
- * Two kind of refresh operation
Auto refresh/ Self refresh
- * Programmable burst access capability ;
- Sequence: Sequential / Interleave
- Length : 1/2/4/8/FP
- * Programmable CAS latency : 2/3
- * 4 Banks can operate independently or simultaneously
- * Burst read/burst write or burst read/single write operation capability
- * Byte wide input and output control by DQML and DQMU inputs
- * One clock of back to back read or write command interval
- * Synchronous power down and clock suspend capability with one clock latency for both entry and exit
- * JEDEC Standard 54Pin BLP PKG

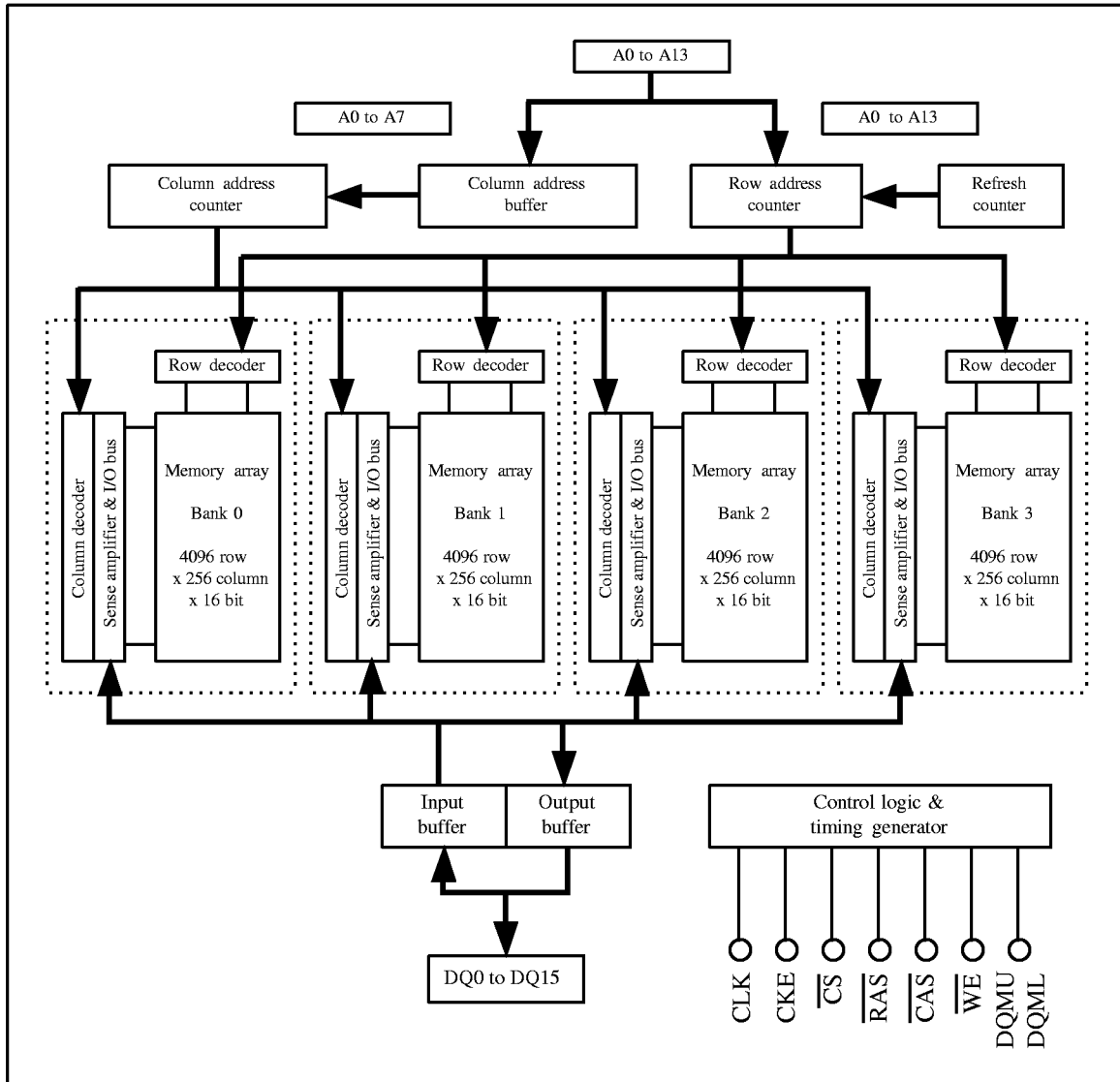
Pin Configuration



Pin Name

CLK	Clock
CKE	Clock Enable
CS	Chip Select
RAS	Row Address Strobe
CAS	Column Address Strobe
WE	Write Enable
A0~A9,A11	Address input
A10 / AP	Address input or Auto Precharge
BA0/A13	Bank select
~BA1/A12	
DQ0~DQ15	Data input / Data output
DQMU/DQML	Data input / output Mask
VCCQ	Vcc for DQ
VSSQ	Vss for DQ
VCC	Power for internal circuit
VSS	Ground for internal circuit
NC	No Connection

Block Diagram



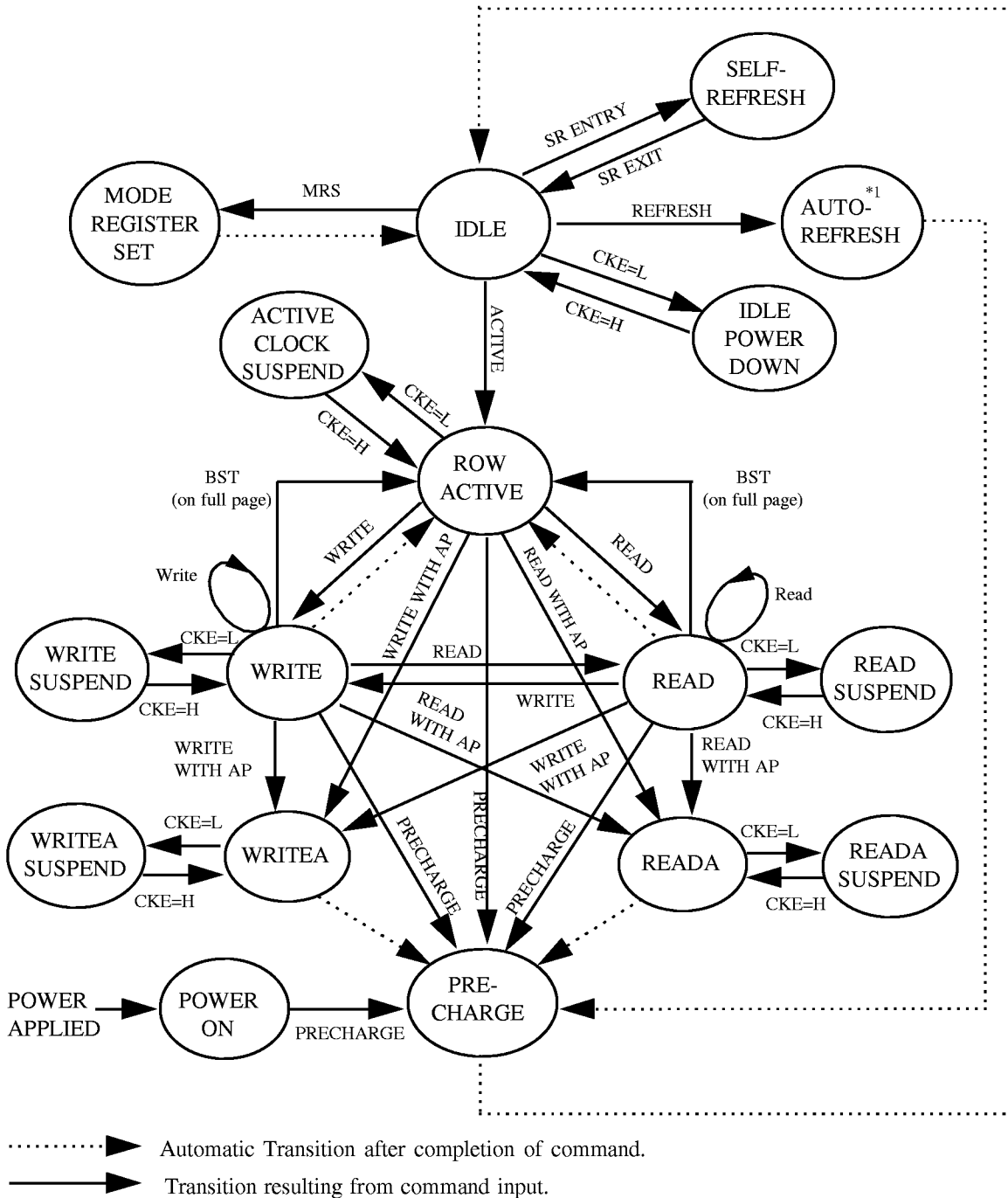
Pin Description

Pin Name	DESCRIPTION
CLK (input pin)	CLK is the master clock input to this pin. The other input signals are referred at CLK rising edge.
CKE (input pin)	This pin determines whether or not the next CLK is valid. If CKE is High, the next CLK rising edge is valid. If CKE is Low, the next CLK rising edge is invalid. This pin is used for power-down and clock suspend modes.
\overline{CS} (input pin)	When \overline{CS} is Low, the command input cycle becomes valid. When \overline{CS} is high, all inputs are ignored. However, internal operations (bank active, burst operations, etc.) are held.
\overline{RAS} , \overline{CAS} , and \overline{WE} (input pins)	Although these pin names are the same as those of conventional DRAMs, they function in a different way. These pins define operation commands (read, write, etc.) depending on the combination of their voltage levels. For details, refer to the command operation section.
A0 ~ A11 (input pins)	Row address (AX0 to AX11) is determined by A0 to A11 level at the bank active command cycle CLK rising edge. Column address (AY0 to AY7; GM72V661641DI/DLI) is determined by A0 to A7 level at the read or write command cycle CLK rising edge. And this column address becomes burst access start address. A10 defines the Precharge mode. When A10 = High at the Precharge command cycle, all banks are precharged. But when A10 = Low at the Precharge command cycle, only the bank that is selected by A12/A13 (BS) is precharged.
A12/A13 (input pin)	A12/A13 are bank select signal (BS). The memory array of the GM72V661641DI/DLI is divided into bank 0, bank 1, bank2 and bank 3. GM72V661641DI/DLI contain 4096-row x 256-column x 16-bits. contain 4096-row x 1024-column x 4-bits. If A12 is Low and if A13 is Low, bank 0 is selected. If A12 is High and A13 is Low, bank 1 is selected. If A12 is Low and A13 is High, bank 2 is selected. If A12 is High and A13 is High, bank 3 is selected.
DQM, DQMU/DQML (input pins)	DQM, DQMU/DQML controls input/output buffers. * Read operation: If DQM, DQMU/DQML is High, The output buffer becomes High-Z. If the DQM, DQMU/DQML is Low, the output buffer becomes Low-Z. * Write operation: If DQM, DQMU/DQML is High, the previous data is held (the new data is not written). If DQM, DQMU/DQML is Low, the data is written.

Pin Description(Continued)

Pin Name	DESCRIPTION
DQ0 ~ DQ15 (I/O pins)	Data is input and output from these pins. These pins are the same as those of a conventional DRAM.
Vcc and Vccq (power supply pins)	3.3 V is applied. (Vcc is for the internal circuit and Vccq is for the output buffer.)
Vss and Vssq (power supply pins)	Ground is connected. (Vss is for the internal circuit and Vssq is for the output buffer.)
NC	No Connection pins.

64M SDRAM Function State Diagram



Note: 1. After the auto-refresh operation, Precharge is performed automatically and enter the IDLE state.

Absolute Maximum Ratings

Parameter	Symbol	Value	Unit	Note
Voltage on any pin relative to Vss	V _T	-0.5 to V _{CC} +0.5 (≤ 4.6 (max))	V	1
Supply voltage relative to Vss	V _{CC}	-0.5 to +4.6	V	1
Short circuit output current	I _{OUT}	50	mA	
Power dissipation	P _T	1.0	W	
Operating temperature	T _{opr}	0 to +70	C	
Storage temperature	T _{stg}	-55 to +125	C	

Notes : 1. Respect to Vss

Recommended DC Operating Conditions (T_a = 0 to + 70C)

Parameter	Symbol	Min	Max	Unit	Note
Supply voltage	V _{CC} , V _{CCQ}	3.0	3.6	V	1
	V _{SS} , V _{SSQ}	0	0	V	
Input high voltage	V _{IH}	2.0	V _{CC} + 0.3	V	1, 2
Input low voltage	V _{IL}	-0.3	0.8	V	1, 3

Notes : 1. All voltage referred to Vss.

2. V_{IH} (max) = 5.6V for pulse width ≤ 3ns

3. V_{IL} (min) = -2.0V for pulse width ≤ 3ns

DC Characteristics (Ta = 0 to 70C, Vcc, Vccq = 3.3V +/- 0.3V, Vss, Vssq= 0 V)

Parameter	Symbol	- 7K	- 7J	- 8	- 10K	Unit	Test conditions	Notes
		Max	Max	Max	Max			
Operating current	ICC1	90	90	90	80	mA	Burst length= 1 trc = min	1, 2, 3
Standby current in power down	ICC2P	2	2	2	2	mA	CKE = VIL, tck = 12 ns	5
Standby current in power down (input signal stable)	ICC2PS	2	2	2	2	mA	CKE=VIL, tck= Infinity	6
		0.4	0.4	0.4	0.4			6,8
Standby current in non power down (CAS Latency=2)	ICC2N	15	15	15	15	mA	CKE,CS = VIH, tck = 12ns	4
		10	10	10	10			4,8
Standby current in non power down (input signal stable)	ICC2NS	5	5	5	5	mA	CKE = VIH, tck = Infinity	4
Active standby current in power down	ICC3P	6	6	6	6	mA	CKE = VIL, tck = 12 ns, DQ = High-Z	1,2,5
		5	5	5	5			1,2,5,8
Active standby current in power down (input signal stable)	ICC3PS	5	5	5	5	mA	CKE = VIL, tck = Infinity	2,6
		4	4	4	4			2,6,8
Active standby current in non power down	ICC3N	30	30	30	30	mA	CKE,CS = VIH, tck = 12 ns, DQ = High-Z	1,2,4
		25	25	25	25			1,2,4,8
Active standby current in non power down (input signal stable)	ICC3NS	20	20	20	20	mA	CKE = VIH, tck = Infinity	2,9
		10	10	10	10			2,8,9
Burst operating current	(CL= 2)	ICC4	130	90	110	90	tck = min BL = 4	1,2,3
	(CL= 3)	ICC4	130	130	165	130		
Refresh current		ICC5	110	110	110	90	trc = min	3
Self refresh current		ICC6	1	1	1	1	VIH >=VCC - 0.2 VIL <=0.2V	7
			0.4	0.4	0.4	0.4		7,8

Parameter	Symbol	- 7K, -7J, -8, -10K		Unit	Test conditions	Notes
		Min	Max			
Input leakage current	I _{LI}	-1	1	uA	0<=V _{in} <=V _{CC}	
Output leakage current	I _{LO}	-1.5	1.5	uA	0<=V _{out} <=V _{CC} DQ = disable	
Output high voltage	V _{OH}	2.4	-	V	I _{OH} = -2 mA	
Output low voltage	V _{OL}	-	0.4	V	I _{OL} =2 mA	

Notes : 1. I_{CC} depends on output load condition when the device is selected. I_{CC} (max) is specified at the output open condition.

2. One bank operation.
3. Addresses are changed once per one cycle.
4. Addresses are changed once per two cycles.
5. After power down mode, CLK operating current.
6. After power down mode, no CLK operating current.
7. After self refresh mode set, self refresh current.
8. L-Version.
9. Input signals are V_{IH} or V_{IL} fixed.

Capacitance (Ta = 25C, V_{CC}, V_{CCQ} = 3.3 V +/- 0.3 V)

Parameter	Symbol	Min.	Max.	Unit	Notes
Input capacitance (CLK)	C _{I1}	2.5	4	pF	1, 3, 4
Input capacitance (Signals)	C _{I2}	2.5	5	pF	1, 3, 4
Output capacitance (DQ)	C _O	4.0	6.5	pF	1, 2, 3, 4

- Notes :
1. Capacitance measured with Boonton Meter or effective capacitance measuring method.
 2. DQM, DQMU/DQML = V_{IH} to disable Dout.
 3. This parameter is sampled and not 100% tested.
 4. Measured with 1.4 V bias and 200mV swing at the pin under measurement.

AC Characteristics (Ta = 0 to 70C, Vcc, Vccq = 3.3 V +/- 0.3 V, Vss, Vssq = 0 V)

Parameter		Symbol	- 7K		- 7J		- 8		- 10K		Unit	Notes
			Min	Max	Min	Max	Min	Max	Min	Max		
System clock cycle time	(CL=2)	t _{CK}	10	-	15	-	12	-	15	-	ns	1
	(CL=3)	t _{CK}	10	-	10	-	8	-	10	-		
CLK high pulse width		t _{CKH}	3	-	3	-	3	-	3	-	ns	1
CLK low pulse width		t _{CKL}	3	-	3	-	3	-	3	-	ns	1
Access time from CLK	(CL=2)	t _{AC}	-	6	-	8	-	8	-	9	ns	1, 2
	(CL=3)	t _{AC}	-	6	-	6	-	6	-	8		
Data-out hold time		t _{OH}	3	-	3	-	3	-	3	-	ns	1, 2
CLK to Data-out low impedance		t _{LZ}	2	-	2	-	2	-	2	-	ns	1, 2, 3
CLK to Data-out high impedance (CL = 2,3)		t _{HZ}	-	6	-	6	-	6	-	7	ns	1, 4
Data-in setup time		t _{DS}	2	-	2	-	2	-	2	-	ns	1
Data-in hold time		t _{DH}	1	-	1	-	1	-	1	-	ns	1
Address setup time		t _{AS}	2	-	2	-	2	-	2	-	ns	1
Address hold time		t _{AH}	1	-	1	-	1	-	1	-	ns	1
CKE setup time		t _{CES}	2	-	2	-	2	-	2	-	ns	1, 5
CKE setup time for power down exit		t _{CESP}	2	-	2	-	2	-	2	-	ns	1
CKE hold time		t _{CEH}	1	-	1	-	1	-	1	-	ns	1
Command ($\overline{\text{CS}}$, $\overline{\text{RAS}}$, $\overline{\text{CAS}}$, $\overline{\text{WE}}$, DQM) setup time		t _{CS}	2	-	2	-	2	-	2	-	ns	1
Command ($\overline{\text{CS}}$, $\overline{\text{RAS}}$, $\overline{\text{CAS}}$, $\overline{\text{WE}}$, DQM) hold time		t _{CH}	1	-	1	-	1	-	1	-	ns	1
Ref/Active to Ref/Active command period		t _{RC}	70	-	70	-	72	-	90	-	ns	1
Active to Precharge command period		t _{RAS}	50	120000	50	120000	48	120000	60	120000	ns	1
Active command to column command (same bank)		t _{RCD}	20	-	20	-	24	-	30	-	ns	1
Precharge to active command period		t _{RP}	20	-	20	-	24	-	30	-	ns	1

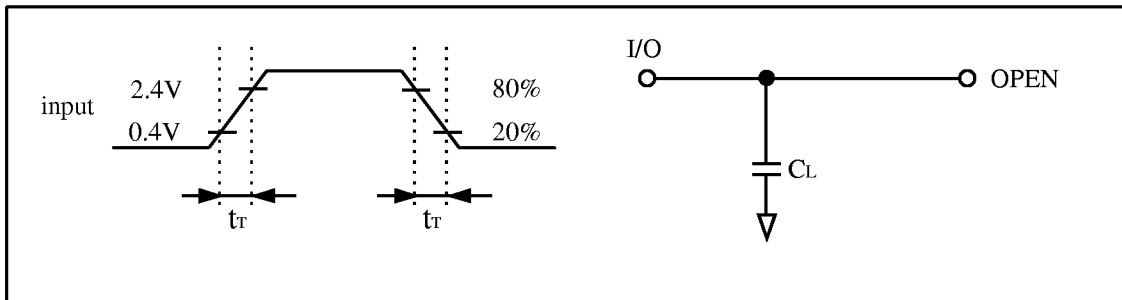
AC Characteristics ($T_a = 0$ to 70°C , $V_{CC}, V_{CCQ} = 3.3\text{ V} \pm 0.3\text{ V}$, $V_{SS}, V_{SSQ} = 0\text{ V}$)
(Continued)

Parameter	Symbol	- 7K		- 7J		- 8		- 10K		Unit	Notes
		Min	Max	Min	Max	Min	Max	Min	Max		
Write recovery or data-in to precharge lead time	t_{RWL}	10	-	10	-	8	-	15	-	ns	1
Active (a) to Active (b) command period	t_{RRD}	20	-	20	-	16	-	20	-	ns	1
Transition time (rise to fall)	t_T	1	5	1	5	1	5	1	5	ns	
Refresh period	t_{REF}	-	64	-	64	-	64	-	64	ms	

- Notes :
1. AC measurement assumes $t_T = 1\text{ ns}$. Reference level for timing of input signals is 1.40V .
 2. Access time is measured at 1.40V . Load condition is $C_L = 50\text{pF}$ without termination.
 3. $t_{LZ}(\text{min})$ defines the time at which the outputs achieves the low impedance state.
 4. $t_{HZ}(\text{max})$ defines the time at which the outputs achieves the high impedance state.
 5. t_{CES} define CKE setup time to CKE rising edge except power down exit command.

Test Condition

- Input and output-timing reference levels: 1.4V
- Input waveform and output load: See following figures



Relationship Between Frequency and Minimum Latency

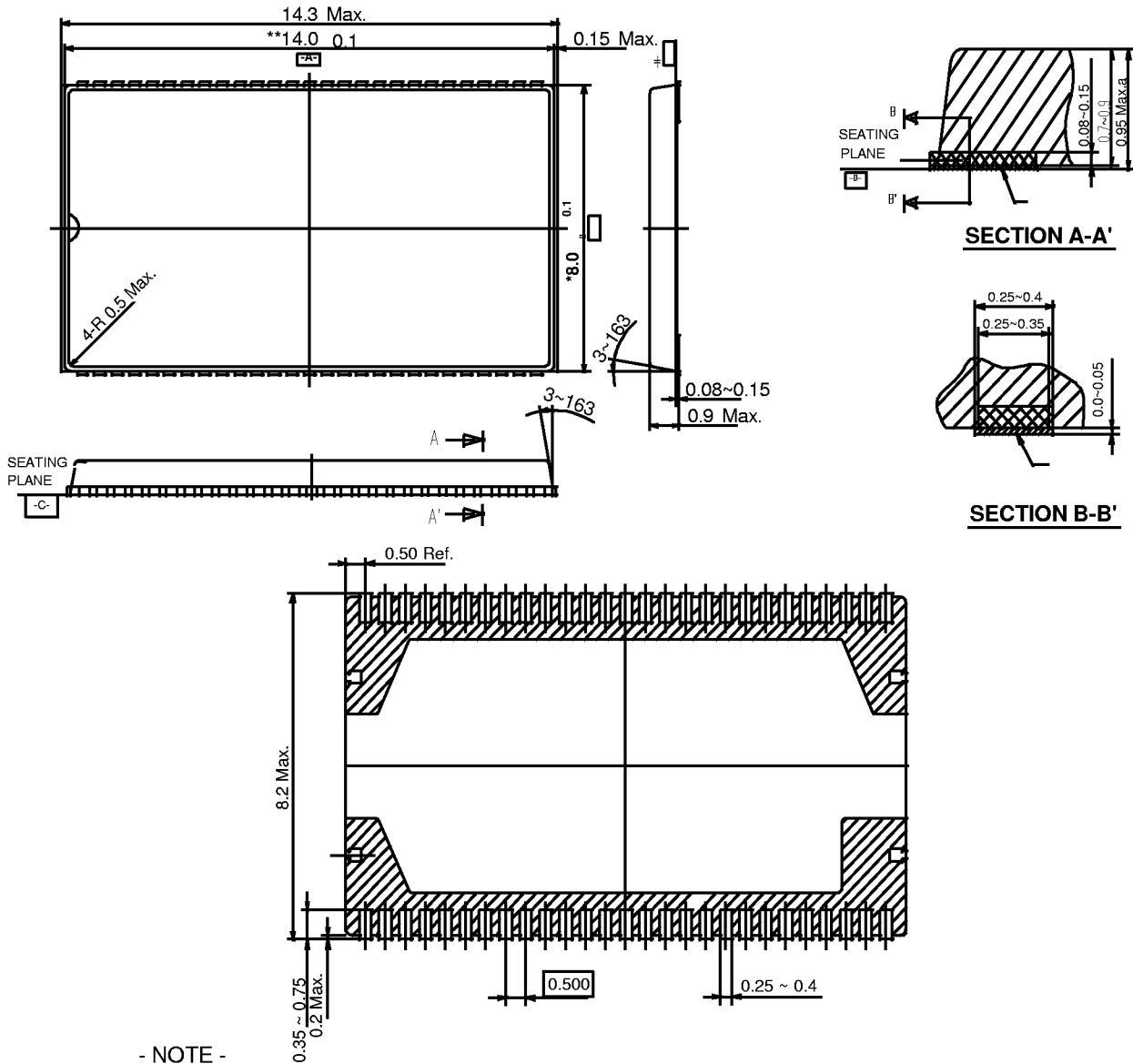
Parameter		Symbol	~ 7K	- 7J		- 8		- 10K		Notes
frequency(MHz)	100		100	66	125	83	100	66		
t _{CK} (ns)	10		10	15	8	12	10	15		
Active command to column command (same bank)		t _{RCD}	2	2	2	3	2	3	2	1
Active command to active command (same bank)		t _{RC}	7	7	6	9	6	9	6	= [t _{RAS} + t _{RP}], 1
Active command to Precharge command (same bank)		t _{RAS}	5	5	4	6	4	6	4	1
Precharge command to active command (same bank)		t _{RP}	2	2	2	3	2	3	2	1
Write recovery or last data-in to Precharge command (same bank)		t _{RWL}	1	1	1	1	1	1	1	1
Active command to active command (different bank)		t _{RRD}	2	2	2	2	2	2	2	1
Self refresh exit time		t _{SREX}	1	1	1	1	1	1	1	
Last data in to active command (Auto Precharge, same bank)		t _{APW}	3	3	3	4	3	4	3	= [t _{RWL} + t _{RP}], 1
Self refresh exit to command input		t _{SEC}	9	9	6	9	6	9	6	= [t _{RC}]
Precharge command to high impedance	(CL=2)	t _{HZP}	2	-	2	-	2	-	2	
	(CL=3)	t _{HZP}	3	3	3	3	3	3	3	
Last data out to active command (auto Precharge) (same bank)		t _{APR}	1	1	1	1	1	1	1	
Last data out to Precharge (early Precharge)	(CL=2)	t _{EP}	-1	-	-1	-	-1	-	-1	
	(CL=3)	t _{EP}	-2	-2	-2	-2	-2	-2	-2	
Column command to column command		t _{CCD}	1	1	1	1	1	1	1	
Write command to data in latency		t _{WCD}	0	0	0	0	0	0	0	
DQM to data in		t _{DID}	0	0	0	0	0	0	0	
DQM to data out		t _{DOD}	2	2	2	2	2	2	2	
CKE to CLK disable		t _{CLE}	1	1	1	1	1	1	1	
Register set to active command		t _{RSA}	1	1	1	1	1	1	1	
CS̄ to command disable		t _{CDD}	0	0	0	0	0	0	0	
Power down exit to command input		t _{PEC}	1	1	1	1	1	1	1	

Relationship Between Frequency and Minimum Latency

Parameter		Symbol	- 7K	- 7J		- 8		- 10K		Notes
frequency(MHz)			100	100	66	125	83	100	66	
t _{CK} (ns)			10	10	15	8	12	10	15	
Burst stop to output valid data hold	(CL=2)	I _{BSR}	1	-	1	-	1	-	1	
	(CL=3)	I _{BSR}	2	2	2	2	2	2	2	
Burst stop to output high impedance	(CL=2)	I _{BSH}	2	-	2	-	2	-	2	
	(CL=3)	I _{BSH}	3	3	3	3	3	3	3	
Burst stop to write data ignore		I _{BSW}	0	0	0	0	0	0	0	

Notes : 1. I_{RCD} to I_{RRD} are recommended value.

Package Dimensions

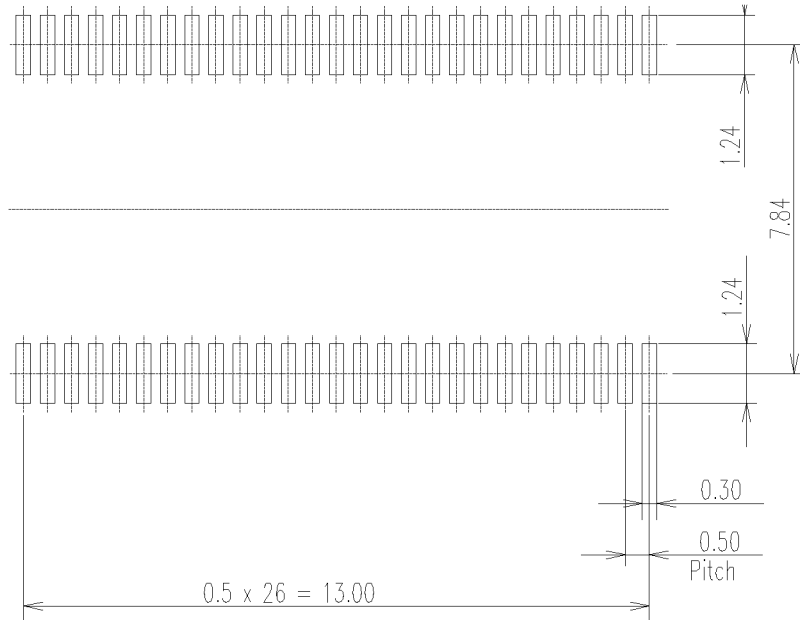


- NOTE -

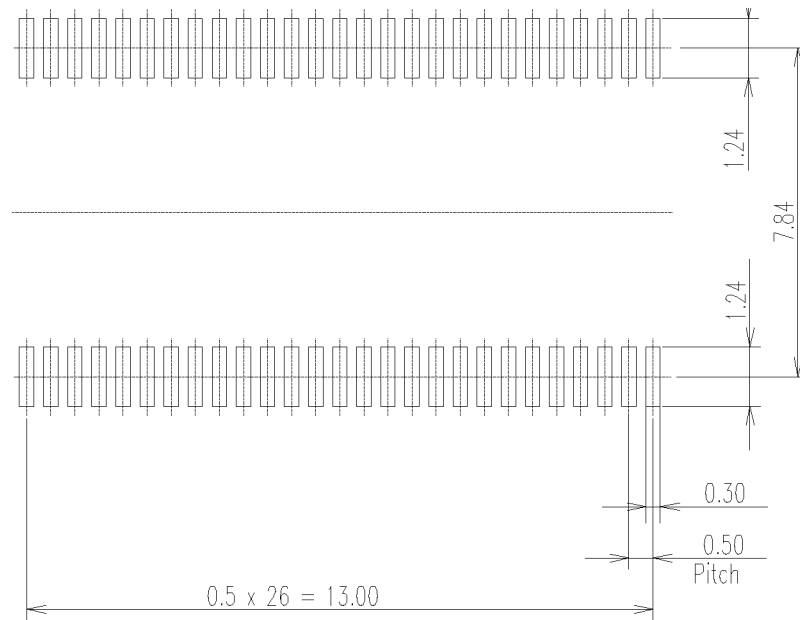
1. DIMENSIONS AND TOLERANCING CONFORM TO ANSI Y14.5M-1982.
2. DATUM **-H-** COINCIDENT WITH TOP OF LEAD, WHERE LEAD EXITS BODY.
3. DATUM **-A-** AND **-B-** TO BE DETERMINED AT DATUM **-H-**
4. ϕ & ϕ^* DIMENSIONS ARE DETERMINED AT DATUM **-H-**
5. ** MARK DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS AND GATE BURRS.
MOLD PROTRUSIONS AND GATE BURRS SHALL NOT EXCEED 0.15 PER SIDE.
6. * MARK DIMENSION DOES NOT INCLUDE INTERLEAD MOLD PROTRUSIONS.
INTERLEAD MOLD PROTRUSIONS SHALL NOT EXCEED 0.15 PER SIDE.
7. LEAD FRAME THICKNESS IS 0.1250.01

DESIGN GUIDELINE FOR 54 pin BLP

LAND DESIGN



METAL MASK DESIGN



Unit : mm
PKG Size: 8 \times 14, 0.5 pitch